



# STS10DN3LH5

Dual N-channel 30 V, 0.019  $\Omega$ , 10 A, SO-8  
STripFET™ V Power MOSFET

## Features

Type	V <sub>DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub>
STS10DN3LH5	30 V	0.021 $\Omega$	10 A

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- Very low switching gate charge
- High avalanche ruggedness
- Low gate drive power losses

## Application

- Switching applications

## Description

This STripFET™V Power MOSFET technology is among the latest improvements, which have been especially tailored to achieve very low on-state resistance providing also one of the best-in-class FOM.

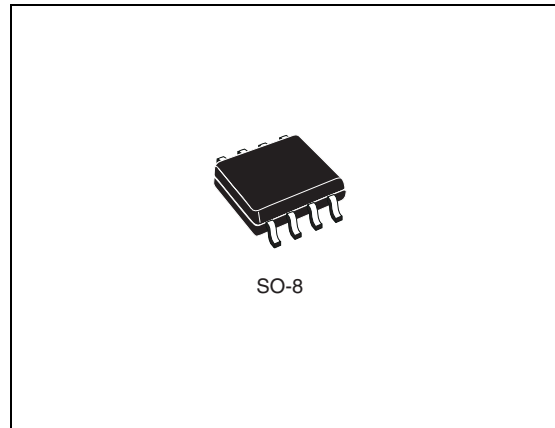


Figure 1. Internal schematic diagram

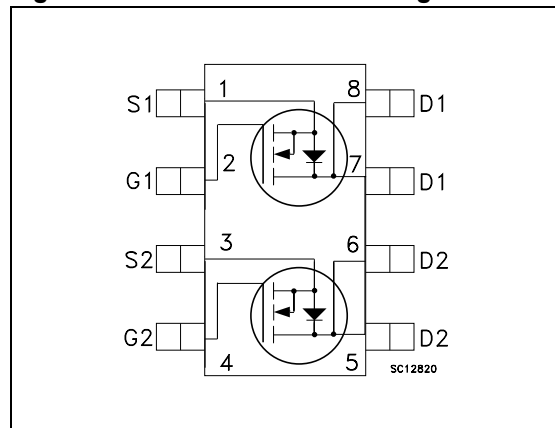


Table 1. Device summary

Order codes	Marking	Package	Packaging
STS10DN3LH5	10DD3L	SO-8	Tape and reel

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	30	V
$V_{GS}$	Gate-Source voltage	$\pm 22$	V
$I_D^{(1)}$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	10	A
$I_D$	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	7	A
$I_{DM}^{(2)}$	Drain current (pulsed)	40	A
$P_{TOT}$	Total dissipation at $T_C = 25\text{ }^\circ\text{C}$	2.5	W
	Derating factor	0.02	W/ $^\circ\text{C}$
$E_{AS}^{(3)}$	Single pulse avalanche energy	50	mJ
$T_J$ $T_{stg}$	Operating junction temperature Storage temperature	- 55 to 150	$^\circ\text{C}$

1. Limited by wire bonding
2. Pulse width limited by safe operating area
3. Starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $I_D = 21\text{ A}$ ,  $L = 0.2\text{ mH}$

**Table 3. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case max	50	$^\circ\text{C/W}$
$R_{thJA}$	Thermal resistance junction-case max	100	$^\circ\text{C/W}$
$T_J$	Maximum lead temperature for soldering purpose	275	$^\circ\text{C}$

## 2 Electrical characteristics

( $T_{CASE} = 25\text{ °C}$  unless otherwise specified)

**Table 4. Static**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown Voltage	$I_D = 250\ \mu\text{A}$ , $V_{GS} = 0$	30			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 30\ \text{V}$ $V_{DS} = 30\ \text{V}$ , $T_c = 125\text{ °C}$			1 10	$\mu\text{A}$ $\mu\text{A}$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = \pm 22\ \text{V}$			$\pm 100$	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 250\ \mu\text{A}$	1			V
$R_{DS(on)}$	Static drain-source on resistance	$V_{GS} = 10\ \text{V}$ , $I_D = 5\ \text{A}$		0.019	0.021	$\Omega$
		$V_{GS} = 4.5\ \text{V}$ , $I_D = 5\ \text{A}$		0.023	0.028	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 25\ \text{V}$ , $f = 1\ \text{MHz}$ , $V_{GS} = 0$	-	475	-	pF
$C_{oss}$	Output capacitance			97		pF
$C_{rss}$	Reverse transfer capacitance			19		pF
$Q_g$	Total gate charge	$V_{DD} = 15\ \text{V}$ , $I_D = 10\ \text{A}$	-	4.6	-	nC
$Q_{gs}$	Gate-source charge	$V_{GS} = 5\ \text{V}$		1.7		nC
$Q_{gd}$	Gate-drain charge	(Figure 14)		1.9		nC
$Q_{gs1}$	Pre $V_{th}$ gate-to-source charge	$V_{DD} = 15\ \text{V}$ , $I_D = 10\ \text{A}$ $V_{GS} = 5\ \text{V}$	-	0.67	-	nC
$Q_{gs2}$	Post $V_{th}$ gate-to-source charge	(Figure 19)		0.84		nC
$R_G$	Gate input resistance	$f = 1\ \text{MHz}$ gate bias Bias = 0 test signal level = 20 mV open drain	-	2.5	-	$\Omega$

**Table 6. Switching on/off (resistive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 15\text{ V}$ , $I_D = 5\text{ A}$ , $R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$ (Figure 13 and Figure 18)	-	4	-	ns
$t_r$	Rise time			22		
$t_{d(off)}$	Turn-off delay time	$V_{DD} = 15\text{ V}$ , $I_D = 5\text{ A}$ , $R_G = 4.7\ \Omega$ , $V_{GS} = 10\text{ V}$ (Figure 13 and Figure 18)	-	13	-	ns
$t_f$	Fall time			2.8		

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit	
$I_{SD}$	Source-drain current		-		10	A	
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				40	A	
$V_{SD}$	Forward on voltage	$I_{SD} = 5\text{ A}$ , $V_{GS} = 0$	-		1.1	V	
$t_{rr}$	Reverse recovery time	$I_{SD} = 10\text{ A}$ , $V_{DD} = 25\text{ V}$ $di/dt = 100\text{ A}/\mu\text{s}$ , (Figure 15)	-	16.2		ns	
$Q_{rr}$	Reverse recovery charge			7.8			nC
$I_{RRM}$	Reverse recovery current			1			A

1. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

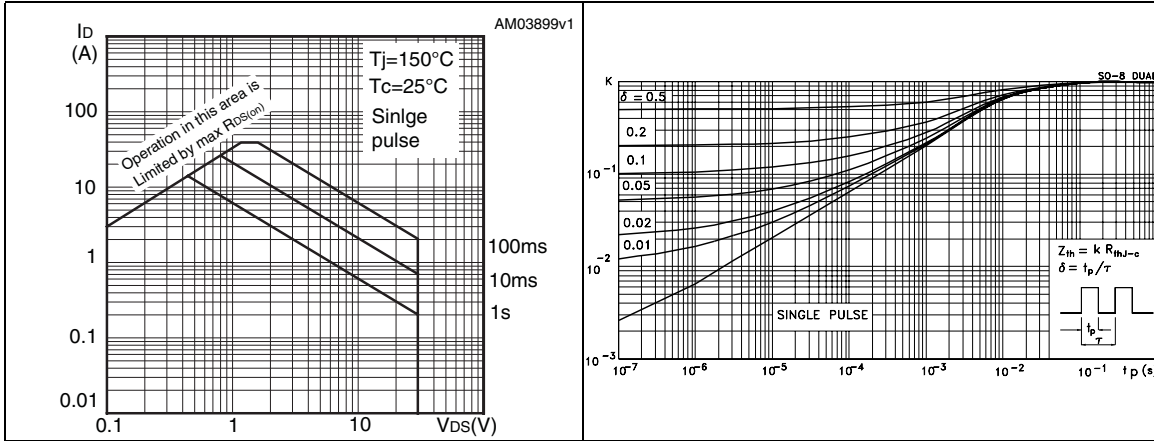


Figure 4. Output characteristics

Figure 5. Transfer characteristics

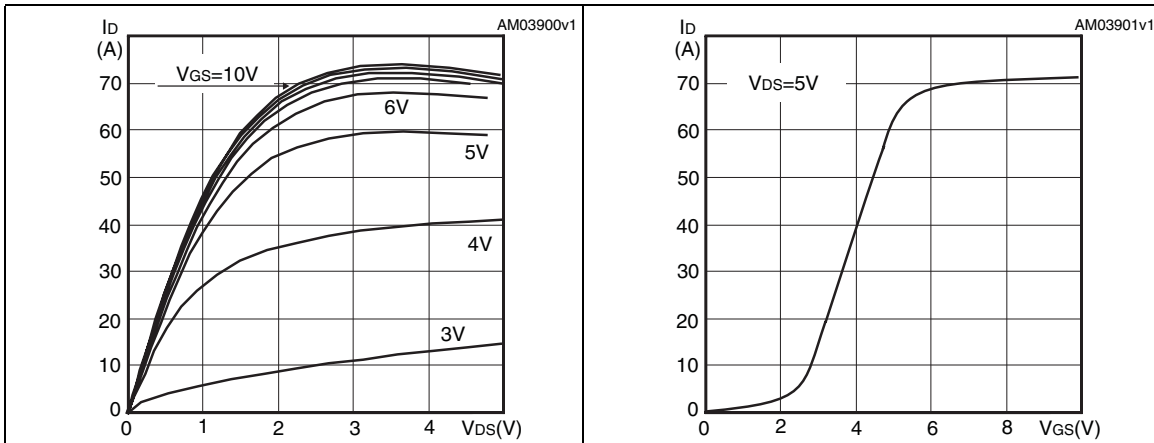


Figure 6. Normalized  $BV_{DSS}$  vs temperature

Figure 7. Static drain-source on resistance

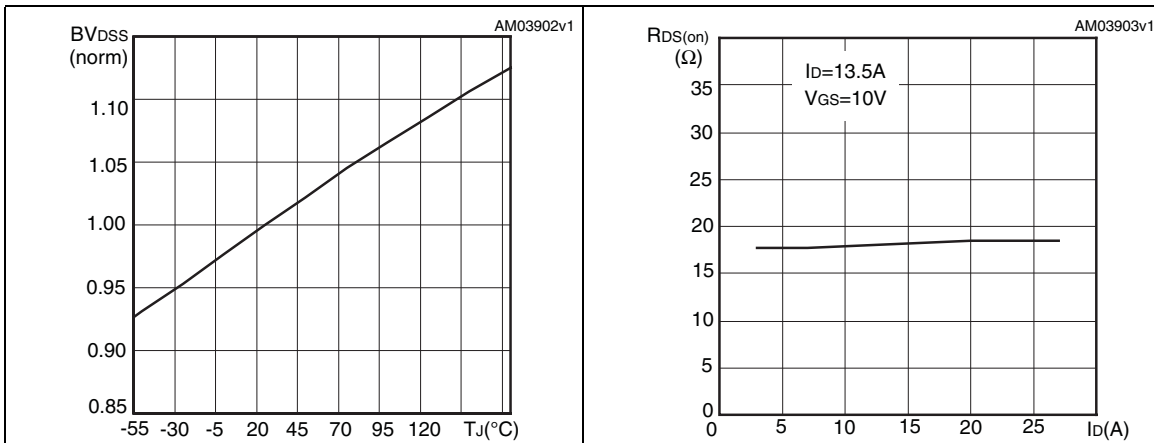


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

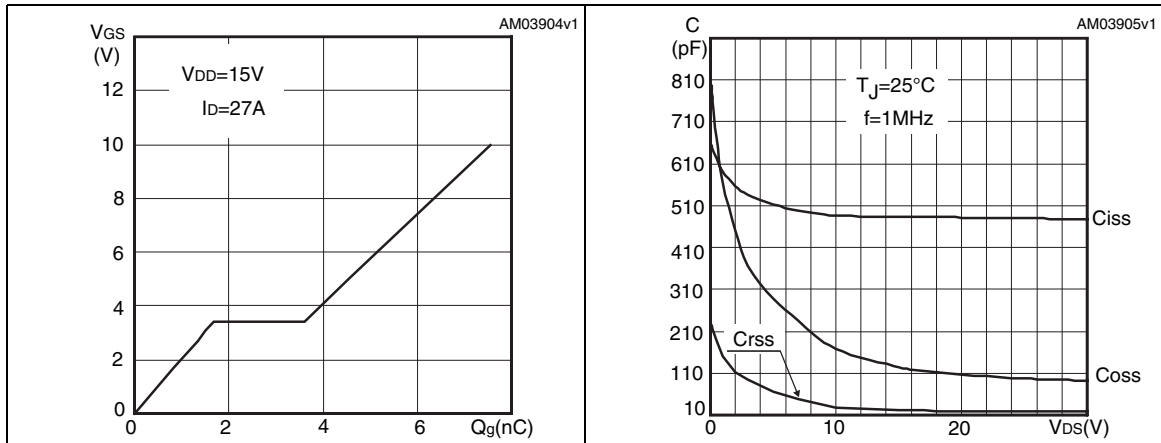


Figure 10. Normalized gate threshold voltage vs temperature Figure 11. Normalized on resistance vs temperature

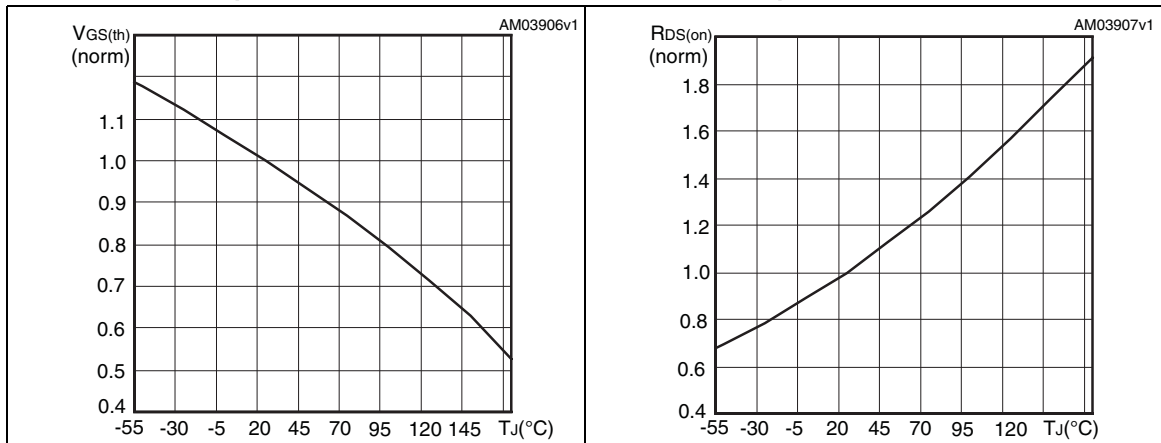
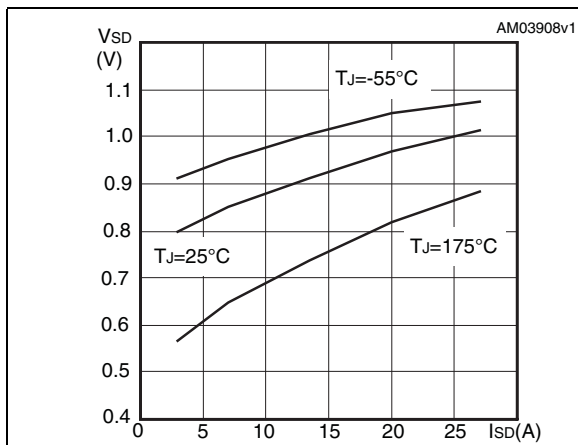


Figure 12. Source-drain diode forward characteristics



### 3 Test circuits

Figure 13. Switching times test circuit for resistive load

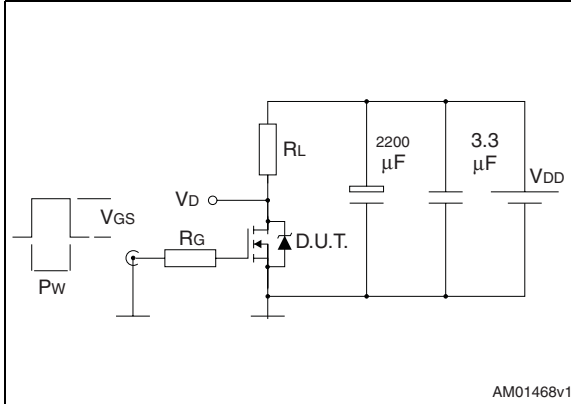


Figure 14. Gate charge test circuit

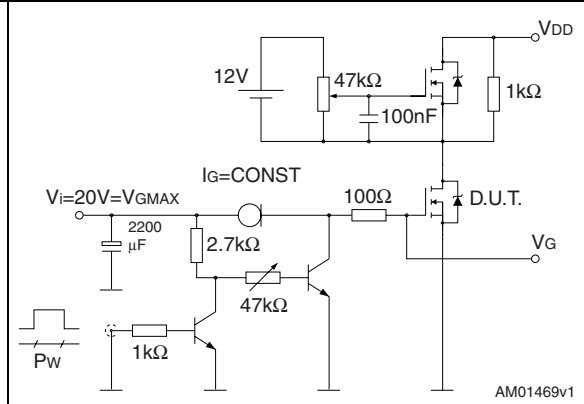


Figure 15. Test circuit for inductive load switching and diode recovery times

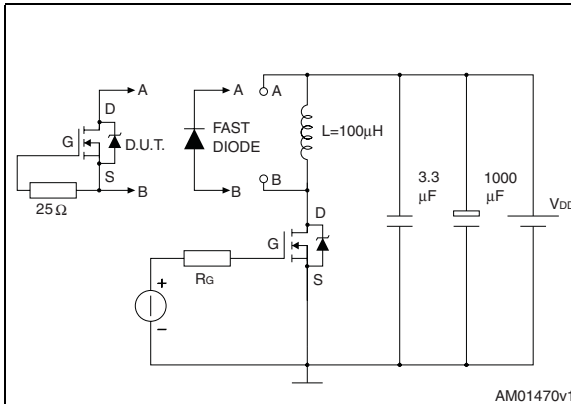


Figure 16. Unclamped inductive load test circuit

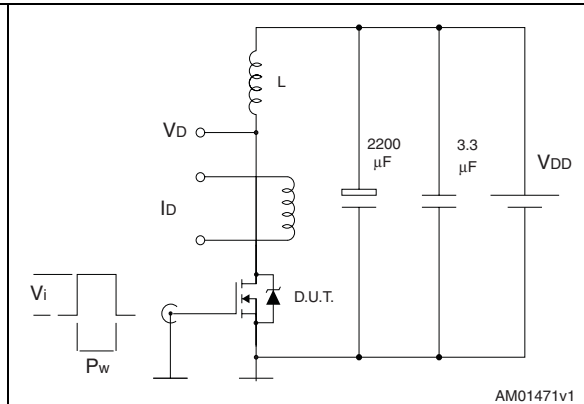


Figure 17. Unclamped inductive waveform

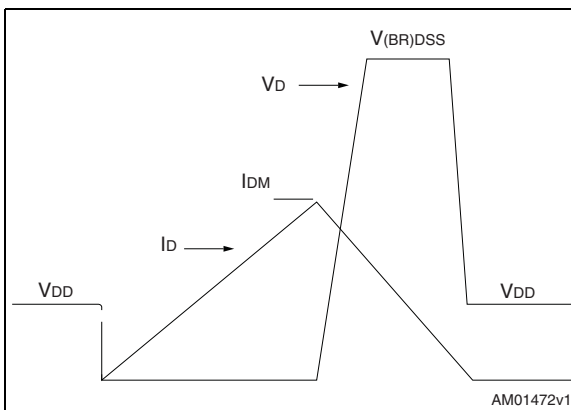


Figure 18. Switching time waveform

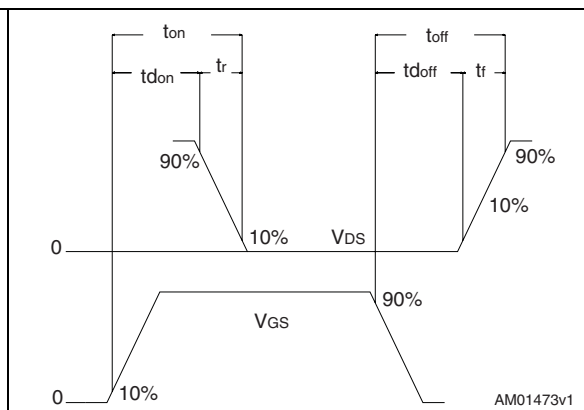
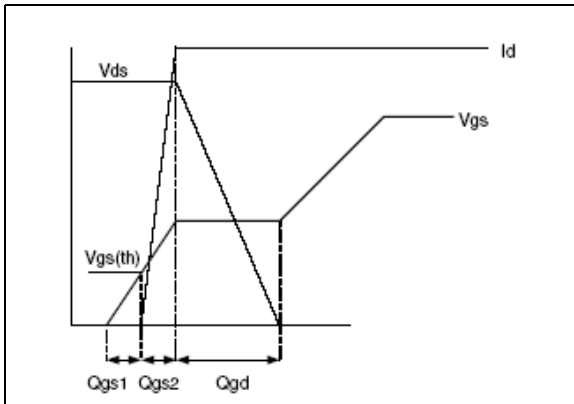




Figure 19. Gate charge waveform

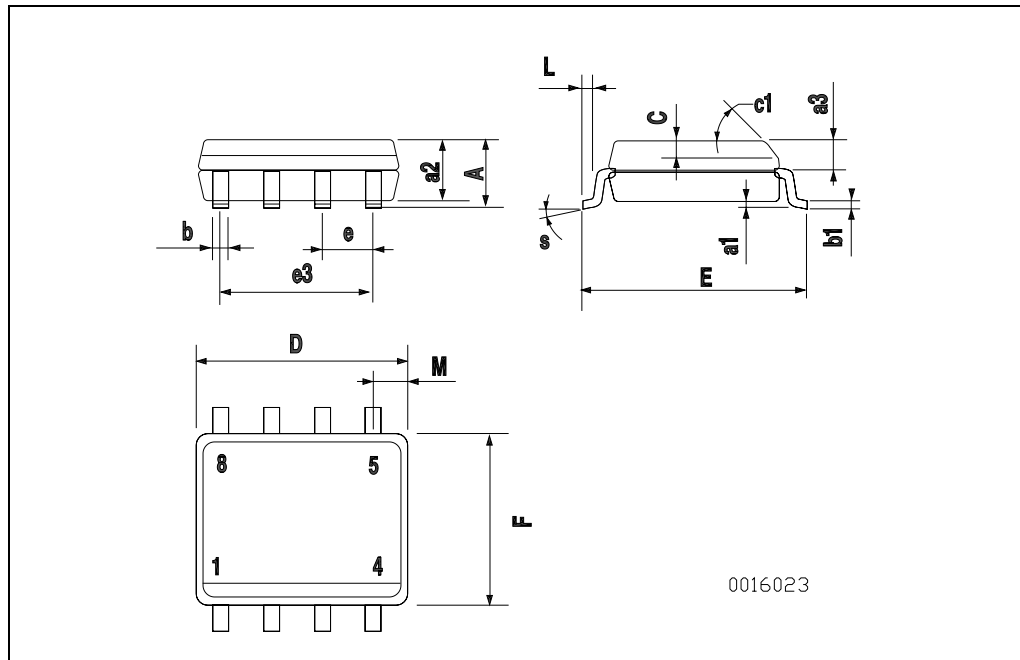


## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

**SO-8 MECHANICAL DATA**

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
C	0.25		0.5	0.010		0.019
c1	45 (typ.)					
D	4.8		5.0	0.188		0.196
E	5.8		6.2	0.228		0.244
e		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
S	8 (max.)					



## 5 Revision history

**Table 8. Document revision history**

Date	Revision	Changes
12-May-2009	1	First release

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